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Substitute for form 1449A/B/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)			Complete If Known		
			Application Number	09/775,346	
			Filing Date	February 1, 2001	
			First Named Inventor	Yechiam YEMINI	
			Art Unit	2662	
			Examiner Name	Donald L. Mills	
Sheet	1	of	1	Attorney Docket Number	19240-227

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Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Country Code ³ -Number-Kind Code ⁴ (if known)				

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NON PATENT LITERATURE DOCUMENTS			
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Examiner Signature		Date Considered	9/27/06
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